

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,266	NAKANO ET AL.	
Examiner	Art Unit	
Vutha Siek	2825	

SEARCHED				
Class	Subclass	Date	Examiner	
716	2,5,8- 11,19-21	3/30/2005	VS	
430	5,311,313	3/30/2005	vs	
438	57-60	3/30/2005	vs	
438	514	3/30/2005	vs	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
7/6	19,21	10/5/05	US	
Interfer	ever Pri-Tout	iº/5/05	15	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST ALL DATABASES	3/30/2005	VS		
EAS all databour See Search History Print out	13/5/05	VS		